

# AO6401A P-Channel Enhancement Mode Field Effect Transistor



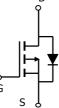
## **General Description**

The AO6401A uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. AO6401A is Pb-free (meets ROHS & Sony 259 specifications).

### Features

$$\begin{split} V_{DS} &= -30V \\ I_D &= -5.0A & (V_{GS} &= -10V) \\ R_{DS(ON)} &< 44m\Omega & (V_{GS} &= -10V) \\ R_{DS(ON)} &< 55m\Omega & (V_{GS} &= -4.5V) \\ R_{DS(ON)} &< 82m\Omega & (V_{GS} &= -2.5V) \end{split}$$





Parameter		Symbol	10 Sec	Steady State	Units
Drain-Source Voltage		V <sub>DS</sub>	-30		V
Gate-Source Voltage		V <sub>GS</sub>	±12		V
Continuous Drain	T <sub>A</sub> =25°C		-5	-3.7	
Current <sup>A</sup>	T <sub>A</sub> =70°C	I <sub>D</sub>	-3.7	-3.2	А
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	-25		
Power Dissipation <sup>A</sup>	T <sub>A</sub> =25°C	D	1.6	1.0	14/
	T <sub>A</sub> =70°C	— P <sub>D</sub>	1.0	0.7	W
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150		°C

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	Р	58	80	°C/W			
Maximum Junction-to-Ambient <sup>A</sup>	Steady State	$R_{ ext{ heta}JA}$	94	120	°C/W			
Maximum Junction-to-Lead <sup>C</sup>	Steady State	$R_{ ext{ heta}JL}$	37	50	°C/W			

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_{\rm D}$ = -250µA, $V_{\rm GS}$ = 0V				V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = -30V, $V_{GS}$ = 0V			-1	μA
		$T_J = 55^{\circ}C$			-5	μA
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 12V$			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = -250 \mu A$ -(		-1	-1.5	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> = -4.5V, V <sub>DS</sub> = -5V	-25			А
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10V, I_{D} = -5.0A$		35	44	m0
		T <sub>J</sub> =125°C		49	62	mΩ
		$V_{GS}$ = -4.5V, I <sub>D</sub> = -4.0A		44	55	mΩ
		$V_{GS}$ = -2.5V, $I_{D}$ = -3.5A		66	82	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5V, I_{D} = -5.0A$		13		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> = -1A,V <sub>GS</sub> = 0V		-0.73	-1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Cur	Current			-1.6	А
DYNAMI	C PARAMETERS					
C <sub>iss</sub>	Input Capacitance			943	1180	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = -15V, f=1MHz		108		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			73		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V, f=1MHz	3	6	12	Ω
SWITCHI	NG PARAMETERS					
Q <sub>g</sub>	Total Gate Charge			9.8	13	nC
Q <sub>gs</sub>	Gate Source Charge	−V <sub>GS</sub> = -4.5V, V <sub>DS</sub> = -15V, _I <sub>D</sub> = -5A		2.0		nC
Q <sub>gd</sub>	Gate Drain Charge			3.3		nC
t <sub>D(on)</sub>	Turn-On DelayTime			5.2		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ = -10V, $V_{DS}$ = -15V, R <sub>L</sub> =3 $\Omega$ ,		6.8		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		42		ns
t <sub>f</sub>	Turn-Off Fall Time	7		15		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> = -5A, dl/dt=100A/μs		21	28	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	, I <sub>F</sub> = -5A, dI/dt=100A/μs		14.3		nC

#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

A: The value of R  $_{0JA}$  is measured with the device mounted on 1in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> = 25°C. in any given application depends on the user's specific board design. The current rating is based on the t  $\leq$ 10s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

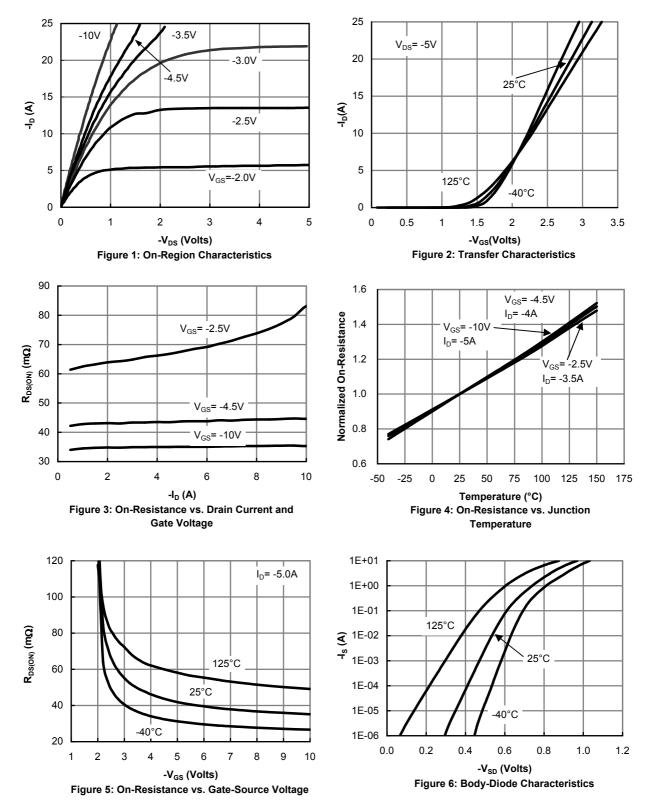
C. The R  $_{\text{BJA}}$  is the sum of the thermal impedence from junction to lead R  $_{\text{BJL}}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < 300  $\mu$ s pulses, duty cycle 0.5% max.

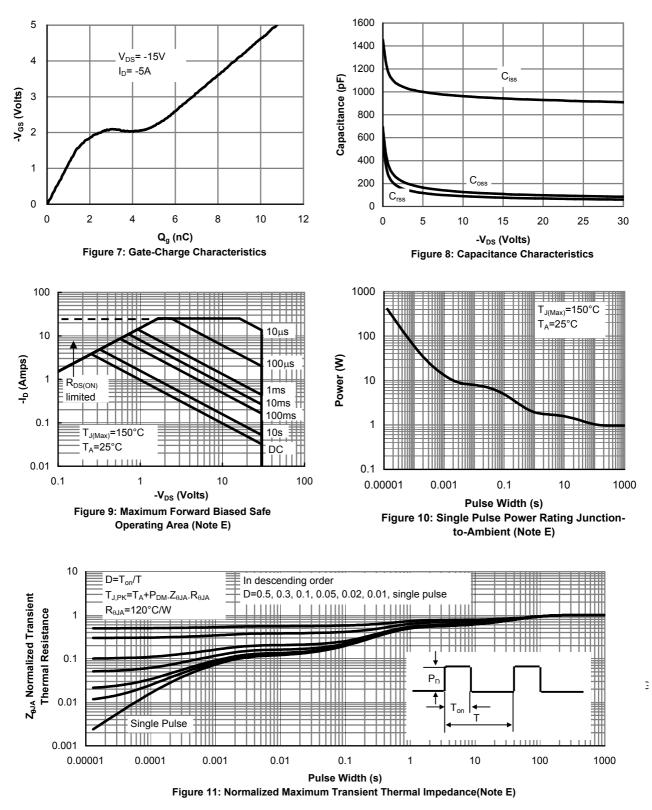
E. These tests are performed with the device mounted on 1 in  $^{2}$  FR-4 board with 2oz. Copper, in a still air environment with T <sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

Rev0 Oct 2007

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